

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/054,709	<b>Applicant(s)/Patent under Reexamination</b> BUEHL ET AL.
<b>Examiner</b> Dominic D. Saltarelli	<b>Art Unit</b> 2611	

**SEARCHED**

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner